

**Search Notes**

Application/Control No.

10/587,142

Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

LONN, MARKUS

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
708	400-409	8/19/2009	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	8/19/2009	MAI